

## RF Power Field Effect Transistors N-Channel Enhancement-Mode Lateral MOSFETs

Designed for PCN and PCS base station applications with frequencies from 1800 to 2000 MHz. Suitable for FM, TDMA, CDMA and multicarrier amplifier applications. To be used in Class AB for PCN-PCS/cellular radio and WLL applications. Specified for GSM1805 – 1880 MHz.

- Typical GSM Performance, Full Frequency Band (1805 – 1880 MHz)  
 Power Gain — 13 dB (Typ) @ 60 Watts  
 Efficiency — 45% (Typ) @ 60 Watts
- Internally Matched, Controlled Q, for Ease of Use
- High Gain, High Efficiency and High Linearity
- Integrated ESD Protection
- Designed for Maximum Gain and Insertion Phase Flatness
- Capable of Handling 10:1 VSWR, @ 26 Vdc, 60 Watts CW Output Power
- Excellent Thermal Stability
- Available with Low Gold Plating Thickness on Leads. L Suffix Indicates 40µ" Nominal.
- In Tape and Reel. R3 Suffix = 250 Units per 56 mm, 13 Inch Reel.

**MRF18060AR3**  
**MRF18060ALSR3**

**1800–1880 MHz, 60 W, 26 V**  
**LATERAL N-CHANNEL**  
**RF POWER MOSFETs**

**CASE 465–06, STYLE 1**  
**NI–780**  
**MRF18060AR3**

**CASE 465A–06, STYLE 1**  
**NI–780S**  
**MRF18060ALSR3**

**Table 1. Maximum Ratings**

Rating	Symbol	Value	Unit
Drain-Source Voltage	V <sub>DSS</sub>	-0.5, +65	Vdc
Gate-Source Voltage	V <sub>GS</sub>	-0.5, +15	Vdc
Total Device Dissipation @ T <sub>C</sub> ≥ 25°C Derate above 25°C	P <sub>D</sub>	180 1.03	W W/°C
Storage Temperature Range	T <sub>stg</sub>	-65 to +150	°C
Operating Junction Temperature	T <sub>J</sub>	200	°C

**Table 2. Thermal Characteristics**

Characteristic	Symbol	Value	Unit
Thermal Resistance, Junction to Case	R <sub>θJC</sub>	0.97	°C/W

**Table 3. ESD Protection Characteristics**

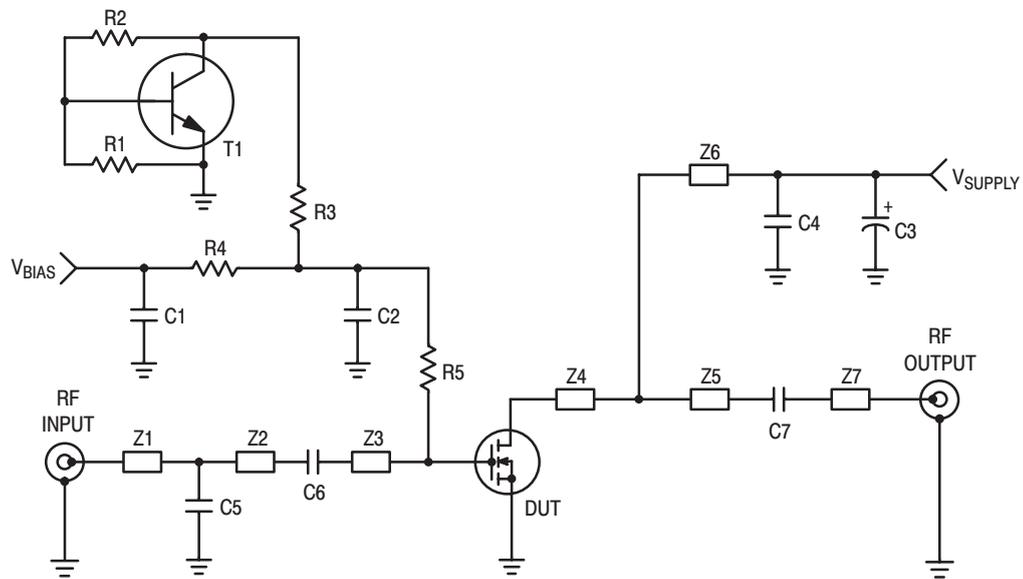
Test Conditions	Class
Human Body Model	2 (Minimum)
Machine Model	M3 (Minimum)

**NOTE – CAUTION** – MOS devices are susceptible to damage from electrostatic charge. Reasonable precautions in handling and packaging MOS devices should be observed.

**Table 4. Electrical Characteristics** ( $T_C = 25^\circ\text{C}$  unless otherwise noted)

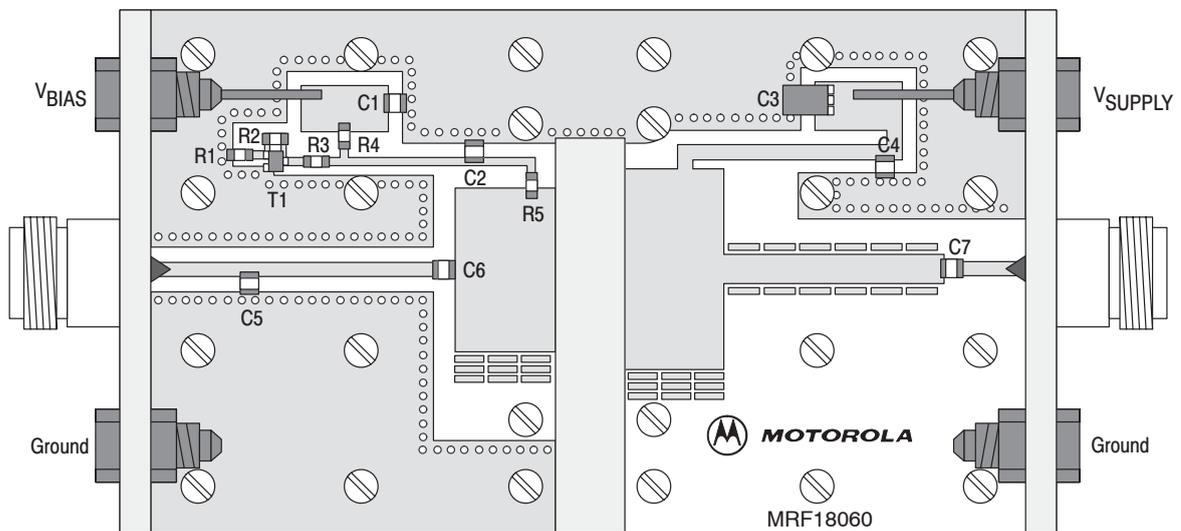
Characteristic	Symbol	Min	Typ	Max	Unit
<b>Off Characteristics</b>					
Drain-Source Breakdown Voltage ( $V_{GS} = 0\text{ Vdc}$ , $I_D = 10\ \mu\text{Adc}$ )	$V_{(BR)DSS}$	65	—	—	Vdc
Zero Gate Voltage Drain Current ( $V_{DS} = 26\text{ Vdc}$ , $V_{GS} = 0\text{ Vdc}$ )	$I_{DSS}$	—	—	6	$\mu\text{Adc}$
Gate-Source Leakage Current ( $V_{GS} = 5\text{ Vdc}$ , $V_{DS} = 0\text{ Vdc}$ )	$I_{GSS}$	—	—	1	$\mu\text{Adc}$
<b>On Characteristics</b>					
Gate Threshold Voltage ( $V_{DS} = 10\text{ Vdc}$ , $I_D = 300\ \mu\text{Adc}$ )	$V_{GS(th)}$	2	—	4	Vdc
Gate Quiescent Voltage ( $V_{DS} = 26\text{ Vdc}$ , $I_D = 500\text{ mAdc}$ )	$V_{GS(Q)}$	2.5	3.9	4.5	Vdc
Drain-Source On-Voltage ( $V_{GS} = 10\text{ Vdc}$ , $I_D = 2\text{ Adc}$ )	$V_{DS(on)}$	—	0.27	—	Vdc
Forward Transconductance ( $V_{DS} = 10\text{ Vdc}$ , $I_D = 2\text{ Adc}$ )	$g_{fs}$	—	4.7	—	S
<b>Dynamic Characteristics</b>					
Input Capacitance (Including Input Matching Capacitor in Package) (1) ( $V_{DS} = 26\text{ Vdc} \pm 30\text{ mV(rms)ac}$ @ 1 MHz, $V_{GS} = 0\text{ Vdc}$ )	$C_{iss}$	—	160	—	pF
Output Capacitance (1) ( $V_{DS} = 26\text{ Vdc} \pm 30\text{ mV(rms)ac}$ @ 1 MHz, $V_{GS} = 0\text{ Vdc}$ )	$C_{oss}$	—	740	—	pF
Reverse Transfer Capacitance ( $V_{DS} = 26\text{ Vdc} \pm 30\text{ mV(rms)ac}$ @ 1 MHz, $V_{GS} = 0\text{ Vdc}$ )	$C_{rss}$	—	2.7	—	pF
<b>Functional Tests</b> (In Freescale Test Fixture, 50 ohm system)					
Common-Source Amplifier Power Gain @ 60 W (2) ( $V_{DD} = 26\text{ Vdc}$ , $I_{DQ} = 500\text{ mA}$ , $f = 1805 - 1880\text{ MHz}$ )	$G_{ps}$	11.5	13	—	dB
Drain Efficiency @ 60 W (2) ( $V_{DD} = 26\text{ Vdc}$ , $I_{DQ} = 500\text{ mA}$ , $f = 1805 - 1880\text{ MHz}$ )	$\eta$	43	45	—	%
Input Return Loss (2) ( $V_{DD} = 26\text{ Vdc}$ , $P_{out} = 60\text{ W CW}$ , $I_{DQ} = 500\text{ mA}$ , $f = 1805 - 1880\text{ MHz}$ )	IRL	—	—	-10	dB
Output Mismatch Stress ( $V_{DD} = 26\text{ Vdc}$ , $P_{out} = 60\text{ W CW}$ , $I_{DQ} = 500\text{ mA}$ VSWR = 10:1, All Phase Angles at Frequency of Tests)	$\Psi$	No Degradation In Output Power Before and After Test			

1. Part is internally matched both on input and output.
2. To meet application requirements, Freescale test fixtures have been designed to cover the full GSM1800 band, ensuring batch-to-batch consistency.



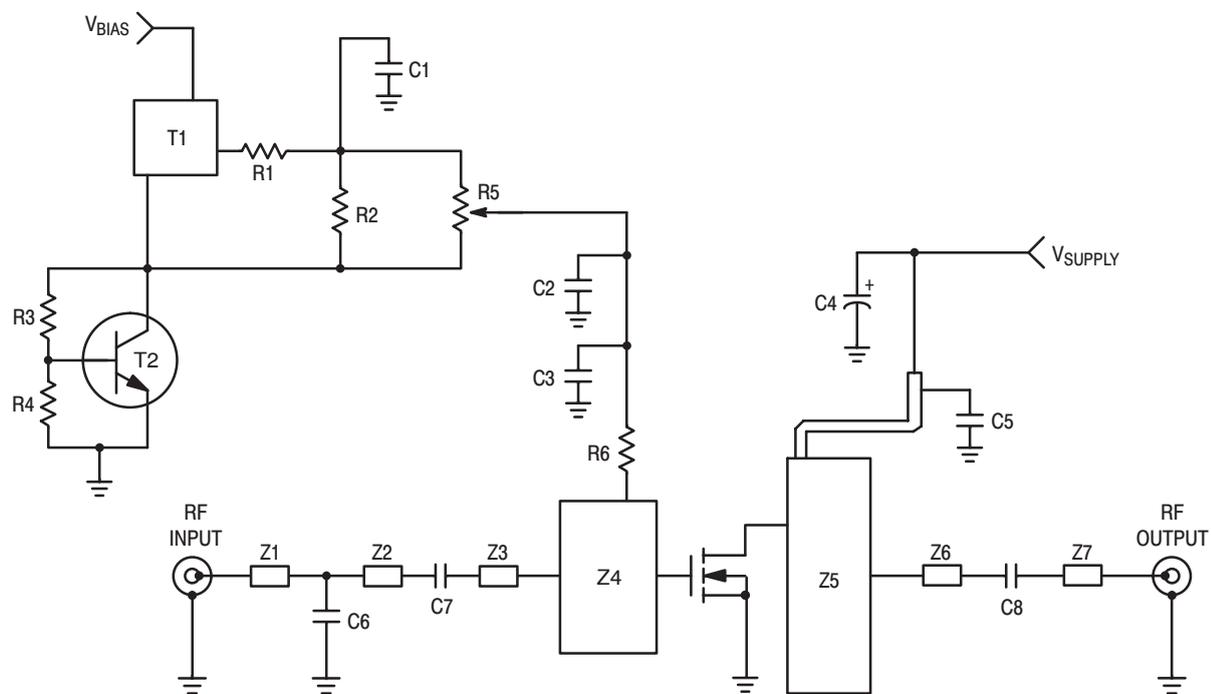
C1	100 nF Chip Capacitor (1203)	Z1	0.47" x 0.09" Microstrip
C2, C4, C7	10 pF Chip Capacitors	Z2	1.16" x 0.09" Microstrip
C3	10 $\mu$ F, 35 V Electrolytic Tantalum Capacitor	Z3	0.57" x 0.95" Microstrip
C5	1.2 pF Chip Capacitor	Z4	0.59" x 1.18" Microstrip
C6	1.0 pF Chip Capacitor	Z5	1.26" x 0.15" Microstrip
R1, R3	2.2 k $\Omega$ Chip Resistors (0805)	Z6	1.15" x 0.09" Microstrip
R2, R4	2.7 k $\Omega$ Chip Resistors (0805)	Z7	0.37" x 0.09" Microstrip
R5	1.1 k $\Omega$ Chip Resistor (0805)		
T1	BC847 Transistor SOT-23		

**Figure 1. 1805 - 1880 MHz Test Fixture Schematic**



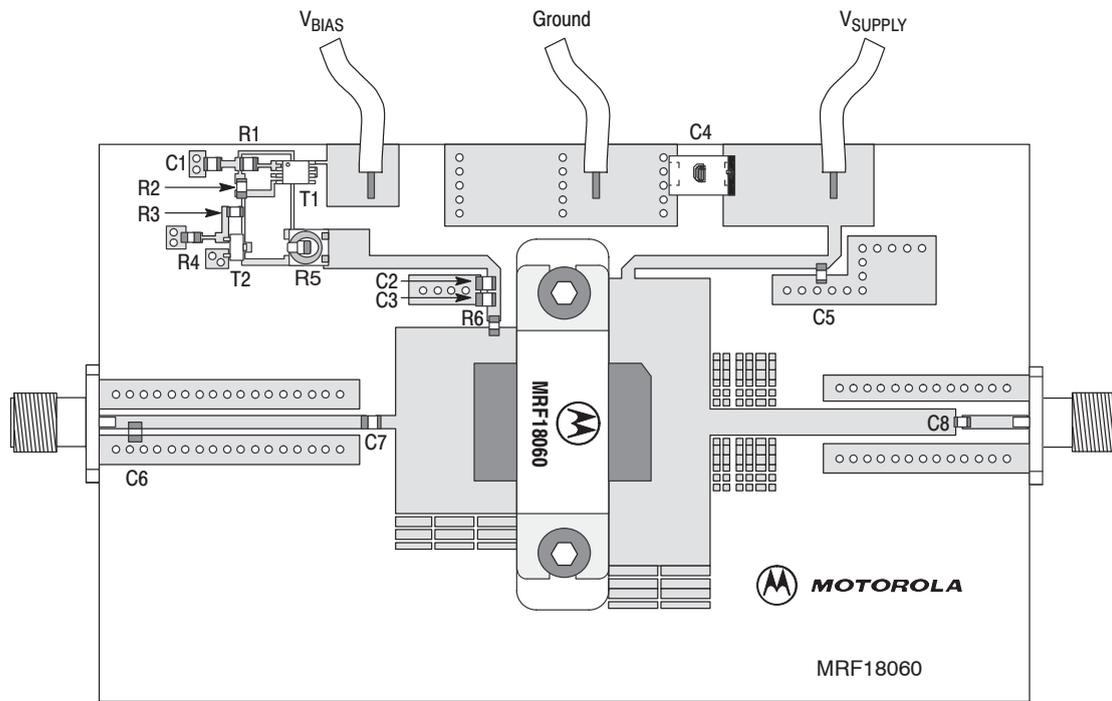
Freescale has begun the transition of marking Printed Circuit Boards (PCBs) with the Freescale Semiconductor signature/logo. PCBs may have either Motorola or Freescale markings during the transition period. These changes will have no impact on form, fit or function of the current product.

**Figure 2. 1805 - 1880 MHz Test Fixture Component Layout**



C1	1 $\mu$ F Chip Capacitor (0805)	T1	LP2951 Micro-8 Voltage Regulator
C2	100 nF Chip Capacitor (0805)	T2	BC847 SOT-23 NPN Transistor
C3, C5, C8	10 pF Chip Capacitors, ACCU-P (0805)	Z1	0.159" $\times$ 0.055" Microstrip
C4	10 $\mu$ F, 35 V Tantalum Electrolytic Capacitor	Z2	0.982" $\times$ 0.055" Microstrip
C6	1.8 pF Chip Capacitor, ACCU-P (0805)	Z3	0.087" $\times$ 0.055" Microstrip
C7	1 pF Chip Capacitor, ACCU-P (0805)	Z4	0.512" $\times$ 0.787" Microstrip
R1	10 $\Omega$ Chip Resistor (0805)	Z5	0.433" $\times$ 1.220" Microstrip
R2, R6	1 k $\Omega$ Chip Resistors (0805)	Z6	1.039" $\times$ 0.118" Microstrip
R3	1.2 k $\Omega$ Chip Resistor (0805)	Z7	0.268" $\times$ 0.055" Microstrip
R4	2.2 k $\Omega$ Chip Resistor (0805)		
R5	5 k $\Omega$ , SMD Potentiometer		Substrate = 0.5 mm Teflon <sup>®</sup> Glass, $\epsilon_r = 2.55$

Figure 3. 1800 - 2000 MHz Demo Board Schematic



Freescall has begun the transition of marking Printed Circuit Boards (PCBs) with the Freescall Semiconductor signature/logo. PCBs may have either Motorola or Freescall markings during the transition period. These changes will have no impact on form, fit or function of the current product.

**Figure 4. 1800 – 2000 MHz Demo Board Component Layout**

TYPICAL CHARACTERISTICS (DATA TAKEN USING WIDEBAND DEMONSTRATION BOARD)

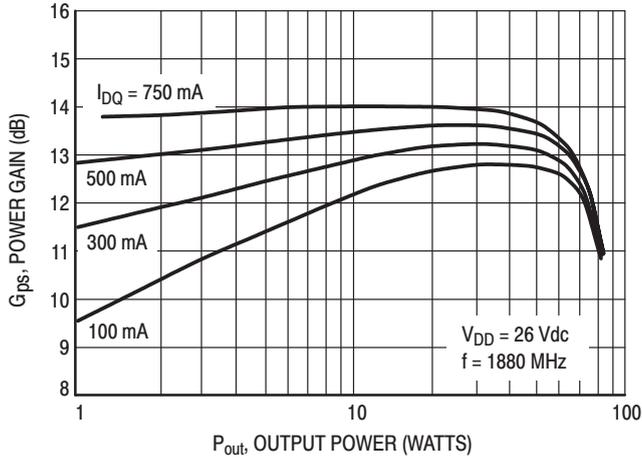


Figure 5. Power Gain versus Output Power

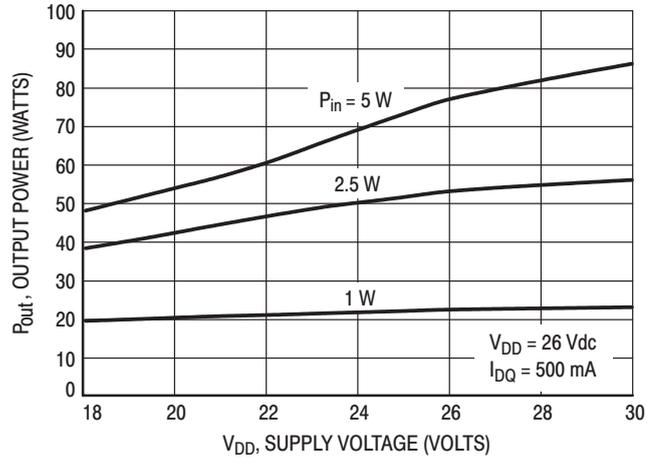


Figure 6. Output Power versus Supply Voltage

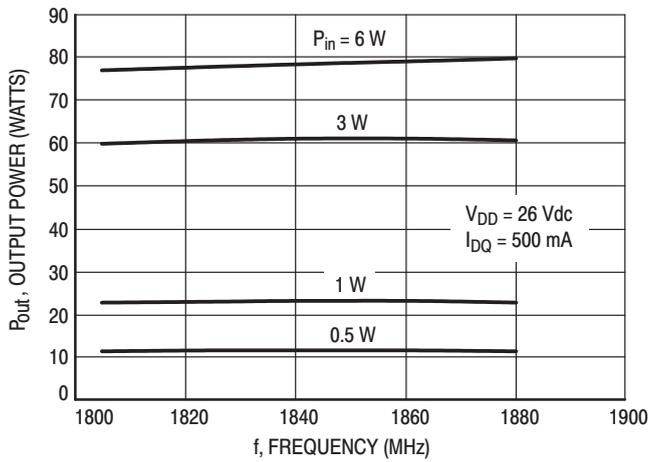


Figure 7. Output Power versus Frequency

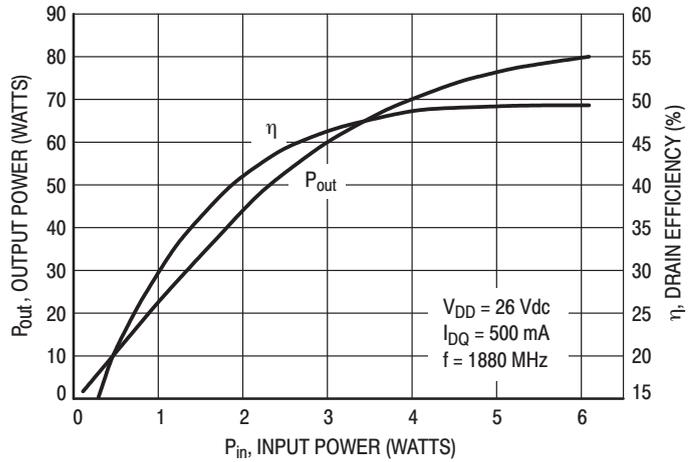


Figure 8. Output Power and Efficiency versus Input Power

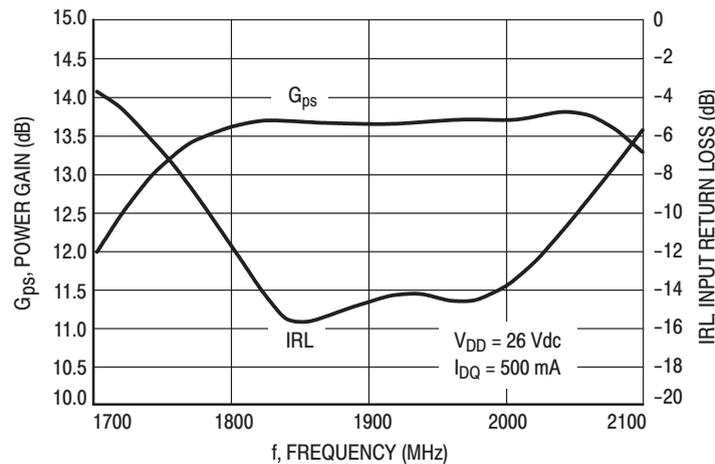
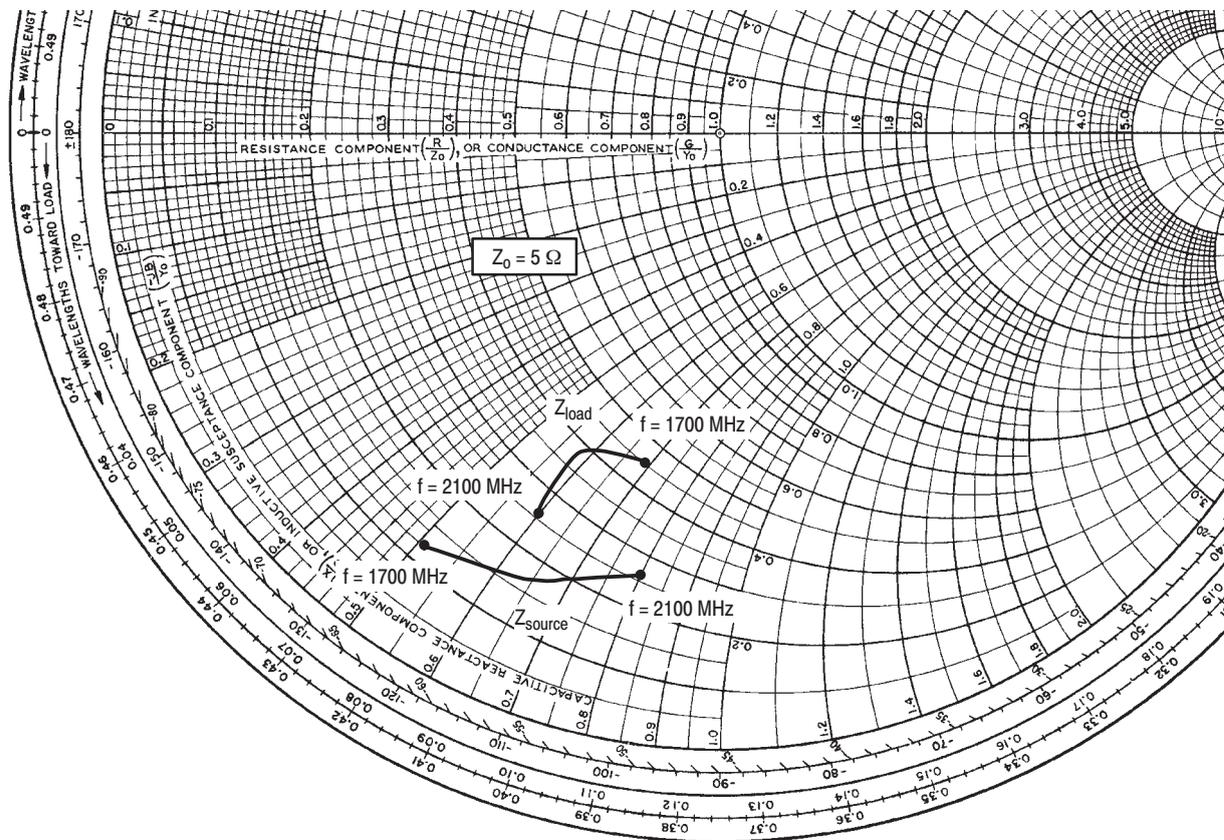


Figure 9. Wideband Gain and IRL (at Small Signal)



$V_{DD} = 26\text{ V}$ ,  $I_{DQ} = 500\text{ mA}$ ,  $P_{out} = 60\text{ W CW}$

f MHz	$Z_{source}$ Ω	$Z_{load}$ Ω
1700	$0.60 - j2.53$	$2.27 - j3.44$
1800	$0.80 - j3.20$	$2.05 - j3.05$
1900	$0.92 - j3.42$	$1.90 - j2.90$
2000	$1.07 - j3.59$	$1.64 - j2.88$
2100	$1.31 - j4.00$	$1.29 - j2.99$

$Z_{source}$  = Test circuit impedance as measured from gate to ground.

$Z_{load}$  = Test circuit impedance as measured from drain to ground.

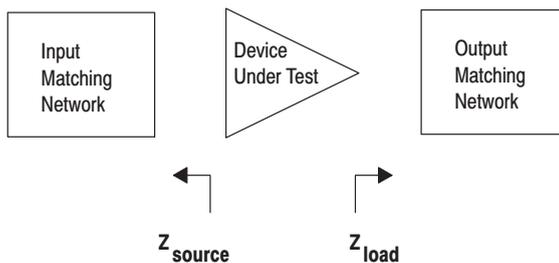
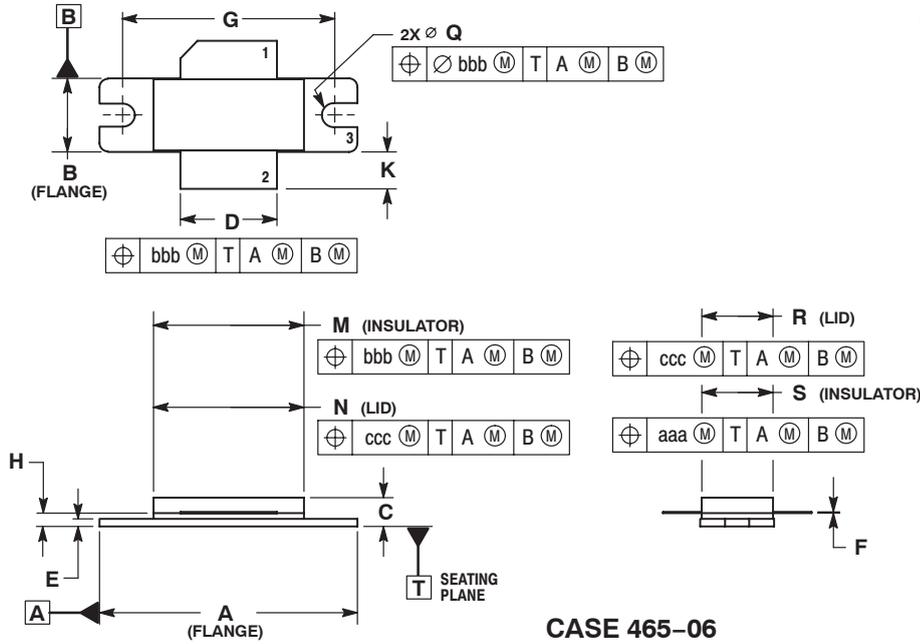


Figure 10. Series Equivalent Source and Load Impedance

## PACKAGE DIMENSIONS

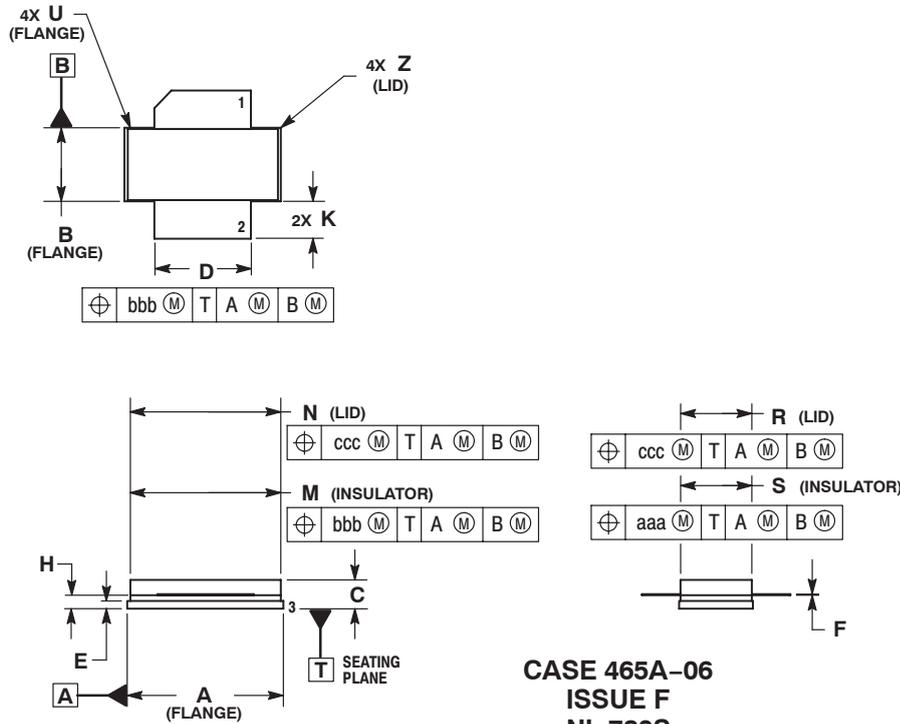


- NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M-1994.
  2. CONTROLLING DIMENSION: INCH.
  3. DELETED
  4. DIMENSION H IS MEASURED 0.030 (0.762) AWAY FROM PACKAGE BODY.

DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	1.335	1.345	33.91	34.16
B	0.380	0.390	9.65	9.91
C	0.125	0.170	3.18	4.32
D	0.495	0.505	12.57	12.83
E	0.035	0.045	0.89	1.14
F	0.003	0.006	0.08	0.15
G	1.100	BSC	27.94	BSC
H	0.057	0.067	1.45	1.70
K	0.170	0.210	4.32	5.33
M	0.774	0.786	19.66	19.96
N	0.772	0.788	19.60	20.00
Q	$\varnothing$ .118	$\varnothing$ .138	$\varnothing$ 3.00	$\varnothing$ 3.51
R	0.365	0.375	9.27	9.53
S	0.365	0.375	9.27	9.52
aaa	0.005	REF	0.127	REF
bbb	0.010	REF	0.254	REF
ccc	0.015	REF	0.381	REF

- STYLE 1:  
 PIN 1. DRAIN  
 2. GATE  
 3. SOURCE

**CASE 465-06  
 ISSUE F  
 NI-780  
 MRF18060AR3**

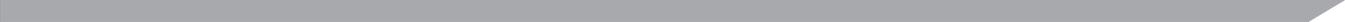


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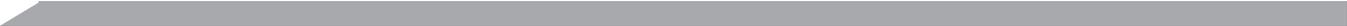
DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	0.805	0.815	20.45	20.70
B	0.380	0.390	9.65	9.91
C	0.125	0.170	3.18	4.32
D	0.495	0.505	12.57	12.83
E	0.035	0.045	0.89	1.14
F	0.003	0.006	0.08	0.15
H	0.057	0.067	1.45	1.70
K	0.170	0.210	4.32	5.33
M	0.774	0.786	19.61	20.02
N	0.772	0.788	19.61	20.02
R	0.365	0.375	9.27	9.53
S	0.365	0.375	9.27	9.52
U	---	0.040	---	1.02
Z	---	0.030	---	0.76
aaa	0.005	REF	0.127	REF
bbb	0.010	REF	0.254	REF
ccc	0.015	REF	0.381	REF

- STYLE 1:  
 PIN 1. DRAIN  
 2. GATE  
 5. SOURCE

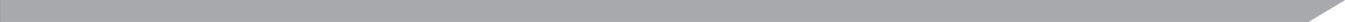
**CASE 465A-06  
 ISSUE F  
 NI-780S  
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# NOTES



## NOTES



# NOTES

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